
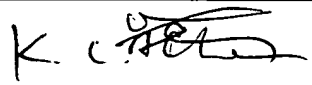
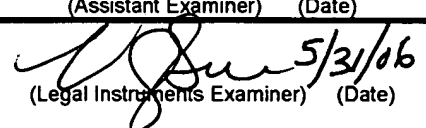


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/687,424	LIAW, JHON JHY	
	Examiner	Art Unit	
	Kin-Chan Chen	1765	

ISSUE CLASSIFICATION									
ORIGINAL					CROSS REFERENCE(S)				
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)			
438		719			438	706			
INTERNATIONAL CLASSIFICATION									
H	0	1	L	21/302					
				/					
				/					
				/					
				/					

(Assistant Examiner) (Date)		 Kin-Chan Chen 05/22/2006 (Primary Examiner) (Date)	Total Claims Allowed: 22	
 (Legal Instruments Examiner) (Date)			O.G. Print Claim(s)	O.G. Print Fig.
			1	3

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA				<input type="checkbox"/> T.D.				<input type="checkbox"/> R.1.47			
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